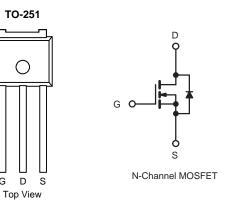


NCE3050I-VB Datasheet N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}$ ($m\Omega$)	I _D (A)	Q _g (Typ.)	
30	7 at V _{GS} = 10 V	50	19 nC	
30	9 at V _{GS} = 4.5 V	45	19110	



FEATURES

- · Halogen-free
- Trench Gen III Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- DC/DC Conversion
 - System Power

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20	V	
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	I _D	50 45 14 ^{b, c} 10 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	150		
Avalanche Current	L = 0.1 mH	I _{AS}	25		
Avalanche Energy	L=0.1 IIII	E _{AS}	40	mJ	
Continuous Source-Drain Diode Current $T_C = 25 \text{ °C}$ $T_A = 25 \text{ °C}$		I _S	15 2.9 ^{b, c}	Α	
$ \begin{array}{c} T_{C} = 25 \ ^{\circ}C \\ \hline T_{C} = 70 \ ^{\circ}C \\ \hline T_{A} = 25 \ ^{\circ}C \\ \hline T_{A} = 70 \ ^{\circ}C \\ \hline \end{array} $		P _D	28 18 3.5 ^{b, c} 2.2 ^{b, c}	w	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RA	HERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient	t ≤ 10 s	R_{thJA}	29	36	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3.6	4.5] 5/ **		

Notes:

- a. Based on T_C = 25 °C.
 b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			•	•	•	•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		33		~\\/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.2		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valtana Duain Comment	1	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	15			Α	
Dunin Course On Chata Desistance		V _{GS} = 10 V, I _D = 10 A		7		m()	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		9		mΩ	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		24		S	
Dynamic ^b			•	•			
Input Capacitance	C _{iss}			1700			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		200		pF	
Reverse Transfer Capacitance	C _{rss}			150		1	
Total Cata Charge		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		33		nC	
Total Gate Charge	Q_g			18			
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		7.3			
Gate-Drain Charge	Q_{gd}			6.2			
Gate Resistance	R_g	f = 1 MHz	0.2	8.0	1.6	Ω	
Turn-On Delay Time	t _{d(on)}			15	30		
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		12	24		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		13	26		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			9	18	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		9	18		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		14	28		
Fall Time	t _f			8 16			
Drain-Source Body Diode Characteristi	cs		•	•			
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			16	Α	
Pulse Diode Forward Current	I _{SM}				32		
Body Diode Voltage	V_{SD}	I _S = 3 A, V _{GS} = 0 V		0.78	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			17	34	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		9.5	19	nC	
Reverse Recovery Fall Time	t _a	$ F - 10 A$, $a / a c = 100 A / \mu s$, $ J = 25 C$		10			
Reverse Recovery Rise Time	t _b			7		ns	

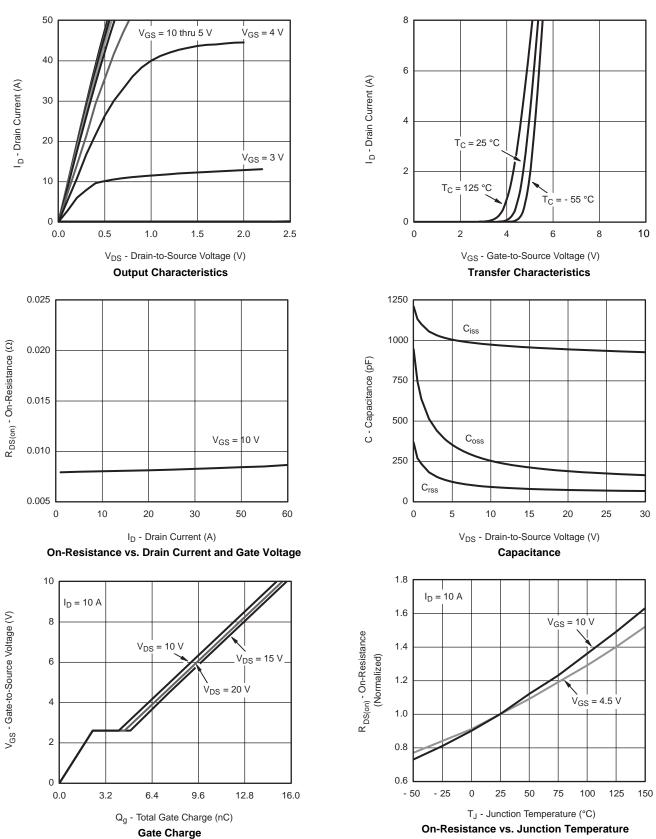
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

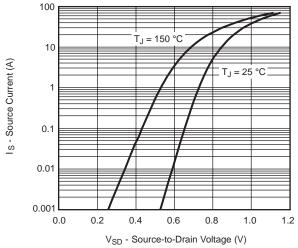
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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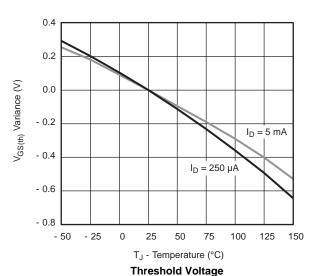








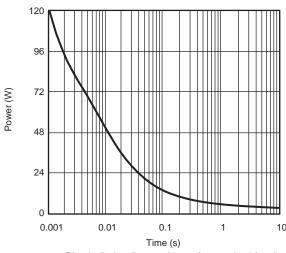
Source-Drain Diode Forward Voltage



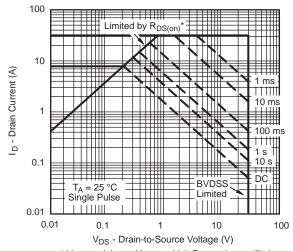
0.06 $I_D = 10^{\circ} A$ 0.05 $R_{DS(on)}$ - On-Resistance (Ω) 0.04 0.03 $T_J = 125$ °C 0.02 0.01 $T_J = 25 \, ^{\circ}C$ 0.00 2 3 0 1 4 5 9

V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)

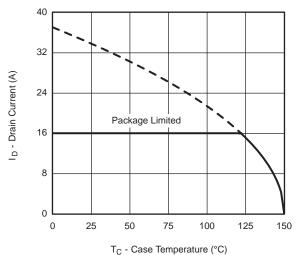


* $V_{GS} > \mbox{minimum } V_{GS}$ at which $R_{DS(on)}$ is specified

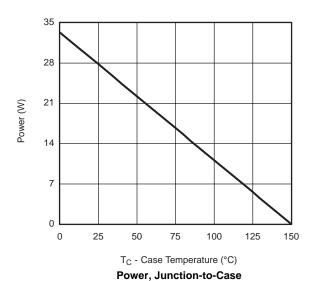
Safe Operating Area, Junction-to-Ambient

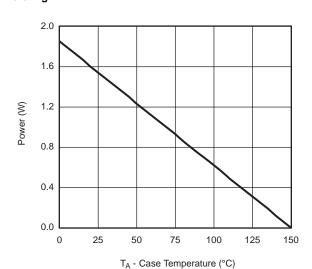
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Current Derating*

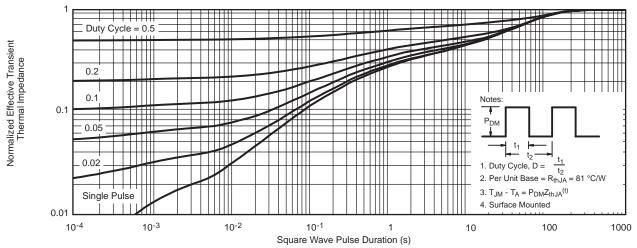




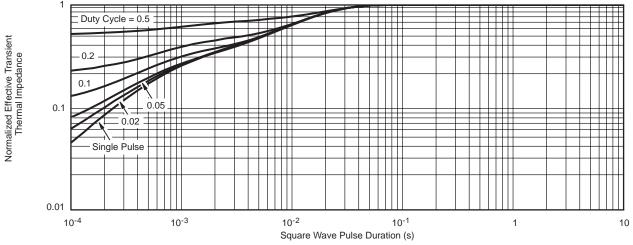
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





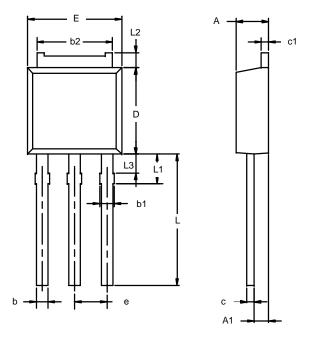
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

	MILLIM	IETERS	INC	HES		
Dim	Min	Max	Min	Max		
Α	2.21	2.38	0.087	0.094		
A 1	0.89	1.14	0.035	0.045		
b	0.71	0.89	0.028	0.035		
b1	0.76	1.14	0.030	0.045		
b2	5.23	5.43	0.206	0.214		
С	0.46	0.58	0.018	0.023		
с1	0.46	0.58	0.018	0.023		
D	5.97	6.22	0.235	0.245		
E	6.48	6.73	0.255	0.265		
е	2.28	BSC	0.090	0.090 BSC		
L	3.89	9.53	0.153	0.375		
L1	1.91	2.28	0.075	0.090		
L2	0.89	1.27	0.035	0.050		
L3	1.15	1.52	0.045	0.060		
ECN: S-0 DWG: 53	3946—Rev. E 346	, 09-Jul-01	•	•		



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